SN54196, SN54197, SN54LS196, SN54LS197, SN54S196, SN54S197, SN74196, SN74197, SN74LS196, SN74LS197, SN74S196, SN74S197, SN74S197, SN74S196, SN74S197, SN74S1

SDLS077

OCTOBER 1976-REVISED MARCH 1988

- Performs BCD, Bi-Quinary, or Binary Counting
- Fully Programmable
- Fully Independent Clear Input
- Input Clamping Diodes Simplify System Design
- Output QA Maintains Full Fan-out Capability In Addition to Driving Clock-2 Input

TYPES	GUARAI COUNT FRI		TYPICAL
	CLOCK 1	CLOCK 2	POWER DISSIPATION
'196, '197	0-50 MHz	0-25 MHz	240 mW
'LS196, 'LS197	0-30 MHz	0-15 MHz	80 mW
'\$196, 'S197	0-100 MHz	0-50 MHz	375 mW

description

These high-speed monolithic counters consist of four d-c coupled, master-slave flip-flops, which are internally interconnected to provide either a divide-by-two and a divide-by-five counter ('196, 'LS196, 'S196) or a divide-by-two and a divide-by-eight counter ('197, 'LS197, 'S197). These four counters are fully programmable; that is, the outputs may be preset to any state by placing a low on the count/load input and entering the desired data at the data inputs. The outputs will change to agree with the data inputs independent of the state of the clocks.

During the count operation, transfer of information to the outputs occurs on the negative-going edge of the clock pulse. These counters feature a direct clear which when taken low sets all outputs low regardless of the states of the clocks.

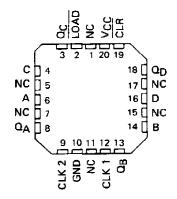
These counters may also be used as 4-bit latches by using the count/load input as the strobe and entering data at the data inputs. The outputs will directly follow the data inputs when the count/load is low, but will remain unchanged when the count/load is high and the clock inputs are inactive.

All inputs are diode-clamped to minimize transmission-line effects and simplify system design. These circuits are compatible with most TTL logic families. Series 54, 54LS, and 54S circuits are characterized for operation over the full military temperature range of $-55\,^\circ\text{C}$ to 125 $^\circ\text{C}$; Series 74, 74LS, and 74S circuits are characterized for operation from 0 $^\circ\text{C}$ to 70 $^\circ\text{C}$.

SN54196, SN54LS196, SN54S196, SN54197, SN54LS197, SN64S197...J OR W PACKAGE SN74196, SN74197...N PACKAGE SN74LS196, SN74S196, SN74LS197, SN74S197...D OR N PACKAGE (TOP VIEW)

LOAD		U14 Vcc
α _C □	2	13 CLR
с□	3	12 QD
ΑC	4	ס⊈וו
Ω _Α □	5	10ДВ
CLK 2	6	эДОВ
GND 🗆	7	8 ☐ CLK 1

\$N54L\$196, \$N54\$196, \$N54L\$197, \$N54\$197...FK PACKAGE (TOP VIEW)



NC - No internal connection

logic symbols[†]

'197, 'LS197, 'S197 '196, 'LS196, 'S196 LOAD (1) CLR (13) CLR 1131 CT - 0 CLK1 (8) (8) DIV2 CLK1 A (4) A (4) QA 10 10 CLK2 (6) (6) B (10) -Qa -QR (10) (2) 121 -Qc (3) -ac an. ·Ωn (11)

Pin numbers shown are for D, J, N, and W packages.

[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

SN54196, SN54197, SN54LS196, SN54LS197, SN54S196, SN54S197, SN74196, SN74197, SN74LS196, SN74LS197, SN74S196, SN74S197, SN74S1

typical count configurations

'196, 'LS196, and 'S196 typical count configurations and function tables are the same as those for '176.

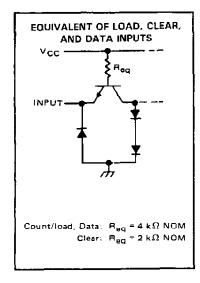
'197, 'LS197, and 'S197 typical count configurations and function tables are the same as those for '177.

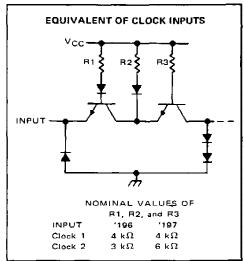
logic diagrams

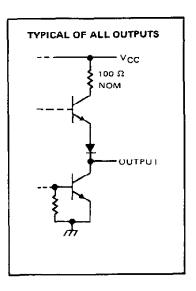
'196, 'L\$196, and '\$196 logic diagrams are the same as those for '176.

'197, 'LS197, and 'S197 logic diagrams are the same as those for '177.

schematics of inputs and outputs







SN54196, SN54197, SN74196, SN74197 50-MHz PRESETTABLE DECADE OR BINARY COUNTERS/LATCHES

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1) .				7 V
Input voltage				5.5 V
Interemitter voltage (see Note 2) .				5,5 V
Operating free-air temperature range:	SN54196, SN54197	Circuits		-55°C to 125°C
	SN74196, SN74197	Circuits	, , ,	0°C to 70°C
Storage temperature range				_65°C to 150°C

NOTES: 1. Voltage values are with respect to network ground terminal.

2. This is the voltage between two emitters of a multiple-emitter transistor. For this circuit, this rating applies between the Clear and Load inputs.

recommended operating conditions

		SN54	4196, SN	54197	SN74	SN74196, SN74197				
		MIN	NOM	MAX	MIN	NOM	MAX	רואט		
Supply voltage, V _{CC}		4.5	5	5.5	4.75	5	5.25	٧		
High-level output current, IOH				-800			-800	μА		
Low-level output current, IOL				16			16	mA		
0	Clock-1 input	0		50	0		50			
Count frequency	Clock-2 input	0		25	0		25	MH:		
	Clock-1 input	10			10					
B. C. C. C.	Clock-2 input	20			20			1		
Pulse width, t _w	Clear	15			15		•	ns		
	Load	20			20					
lance baddelen a dear Alexa 21	High-level data	tw(load)			tw(load)					
Input hold time, th (see Nate 3)	Low-level data	t _{w{load}}			tw(foad)			ns		
January and January 1	High-level data	10			10					
Input setup time, t _{su} (see Note 3)	Low-level data	15			15			ns		
Count enable time, ten (see Note 4)		20			20			ns		
Operating free-air temperature, TA		-55		125	0		70	,°C		

- NOTES: 3. Setup and hold times are with respect to the falling edge of the load input.
 - Minimum count enable time is the interval immediately preceding the negative-going edge of the clock pulse during which
 interval the count/load and clear inputs must both be high to ensure counting.

SN54196, SN54197, SN74196, SN74197 50-MHz PRESETTABLE DECADE OR BINARY COUNTERS/LATCHES

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	1	TEST CONDITIO	Met	SN54	196, SN	74196	SN54	197, SN	74197	
	TATIMIL 121		TEST COMDITIO	1112	MIN	TYP‡	MAX	MIN	TYP‡	MAX	TINU
VIH	High-level input voltage				2			2			V
VIL	Low-level input voltage						0.8			0.8	V
VIK	Input clamp voltage		V _{CC} = MIN, I ₁ = -12	mA			-1.5			-1.5	V
Vон	High-level output voltag	e	V _{CC} = MIN, V _{IH} = 2 ¹ V _{IL} = 0.8 V, I _{OH} = -8		2.4	3.4		2.4	3.4		v
VoL	Low-level output voltage	<u> </u>	V _{CC} = MIN, V _{IH} = 2° V _{IL} = 0.8 V, I _{OL} = 16	٧,		0.2	0.4		0.2	0.4	V
l _I	Input current at maximu	m input voltage	V _{CC} = MAX, V ₁ = 5.5	V			1			1	mΑ
		Data, Load					40			40	
Ιн	High-level input current	Clear, clock 1	$V_{CC} = MAX, V_1 = 2.4$	V			80			80	μА
		Clock 2	7				120			80	ĺ
-	_	Data, Load					-1.6		***************************************	-1.6	
1	Law law line is a correct	Clear],,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,				-3.2			-3.2	İ
ΊL	Low-level input current	Clock 1	VCC = MAX, VI = 0.4	V			-4.8			-4.8	mΑ
		Clock 2	7				-6.4			-3.2	
1	Short-circuit output curr	ant 8	V	SN54'	-20		-57	-20		-57	
os	Short-circuit output curr	ents	VCC = MAX	SN74'	-18		57	-18		-57	mΑ
loc	Supply current		V _{CC} = MAX, See Note 5			48	59		48	59	mΑ

NOTE 5: ICC is measured with all inputs grounded and all outputs open.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER#	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		SN5419 SN7419		l	N5419		UNIT						
	(IIII-O1)	10011017		MIN	TYP	MAX	MIN	TYP	MAX	1						
fmax	Clock 1	QA		50	70		50	70	•	MHz						
tPLH	Clock 1	QA			7	12		7	12							
^t PHL	GIOCK I	Ψ _A			10	15		10	15	ns						
ŧРLН	Clock 2	o _B			12	18		12	18							
tPHL_	CIGER 2			-	14	21		14	21	ns						
^t PLH	Clock 2	Q _C			24	36		24	36							
tPHL	CIDEN 2		$C_L = 15 pF$,		28	42		28	42	ns						
₹PLH	Clock 2	Q _D	$R_L = 400 \Omega$, See Note 6		14	21		36	54							
₹PHL	GIOCK 2	40			12	18		42	63	ns						
tpLH	A, B, C, D	0. 0. 0. 0.	α _A , α _B , α _C , α _D	04 05 05 05			16	24		16	24					
tPHL .	1, 3, 0, 5	-A, -B, -C, -C)	α ₀ ,		25	38		25	38	ns						
†PLH	Load	Anv	Anv	Anv	Апу	Anv	Anv	Anv			22	33		22	33	
tPHL		7			24	36	-	24	36	ns						
[†] PHL	Clear	Any			25	37		25	37	ns						

 $^{^{\#}}f_{\text{max}}$ = maximum count frequency.

NOTE 6: Load circuit, input conditions, and voltage waveforms are the same as those shown for the '176, '177 except that testing f_{max}, V_{IL} = 0.3 V.



[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25 ^{\circ}\text{C}$.

Not more than one output should be shorted at a time.

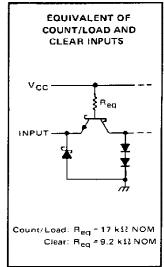
¹⁰A outputs are tested at I_{OL} = 16 mA plus the limit value of I_{IL} for the clock-2 input. This permits driving the clock-2 input while fanning out to 10 Series 54/74 loads.

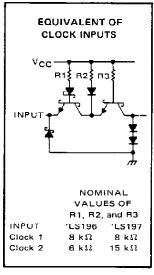
tpLH = propagation delay time, low-to-high-level output.

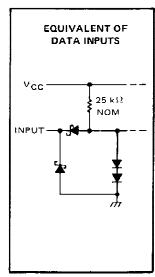
tpHL ≡ propagation delay time, high-to-low-level autput.

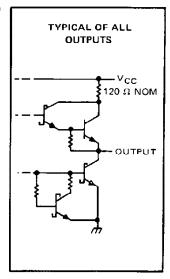
SN54LS196, SN54LS197, SN74LS196, SN74LS197 30-MHz PRESETTABLE DECADE OR BINARY COUNTERS/LATCHES

schematics of inputs and outputs









absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature range: SN54LS196, SN54	LS197 Circuits55°C to 125°C
SN74LS196, SN74	LS197 Circuits 0°C to 70°C
Storage temperature range	

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			SN54LS1	96, SN5	4LS197	SN74LS1	UNIT		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.75	5	5.25	٧
IOH	High-level output current			-	-400			-400	μА
loL	Low-level output current				4			В	mΑ
	Count frequency	Clock-1 input	0		30	0		30	
	Count frequency	Clock-2 input	0		15	0		15	MHz
		Clock-1 input	20			20			
	Pulse width	Clock-2 input	30			30			
t _w	Fulse Width	Clear	15			15			ns
		Load	20			20	•		
	Input hold time, (see Note 3)	High-level data	tw(loai	d)		tw(loa	d)		
th	imput noid time, isee Note 3/	Low-level data	tw(load	1)		tw(loa	d١		пs
	1	High-level data	10		*****	10	•		
^t su	Input setup time, (see Note 3)	Low-level data	15			15			ns
		Clock 1	30			30		1	
^t enable	Count enable time, (see Note 4)	Clock 2	50	•		50			ns
Тд	Operating free-air temperature	•	55		125	0		70	°C

NOTES: 3. Setup and hold times are with respect to the falling edge of the load input.

4. Minimum count enable time is the interval immediately preceding the negative-going edge of the clock pulse during which interval the count/load and clear inputs must both be high to ensure counting.

SN54LS196, SN54LS197, SN74LS196, SN74LS197 30-MHz PRESETTABLE DECADE OR BINARY COUNTERS/LATCHES

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

					_+		V54LS1		ł	174LS1	-	
	PARAMI	EIER	l LES	ST CONDITION	51		N54LS19 TYP‡		 	174 LS 1 TYP‡		UNIT
ViH	High-level input v	oltage			· ·	2	ITF+	MAY	2	115+	MAY	v
VIL	Low-level input v					├- <u>-</u>		0.7		-	0.8	
	Input clamp volta		VCC = MIN,	I _I = -18 mA				-1.5			−1.5	V
νон	High-level output	t voltage	V _{CC} = MIN,		4	2.5	3.4		2.7	3.4		v
Voi	Low-level output	voltage	VCC = MIN,	V _{IH} = 2 V,	IOL = 4 mA		0,25	0.4		0,25	0.4	· v
*UL			VIL = VIL max		IOL = 8 mAf				<u> </u>	0.35	0.5	<u>'</u>
	Input current	Data, Load	!					0.1			0.1	
l ₁	at maximum	Clear, clock 1	Vcc - MAX.	CC + MAX, V _I = 5.5 V				0,2			0.2	mA
-1	input voltage	Clock 2 of 'LS196	1.00	.,				0.4			0.4	''''
		Clock 2 of LS197						0.2			0.2	
		Data, Load						20			20	
ш	High-level	Clear, clock 1	V _{CC} = MAX,	V1=27V				40			40	μД
'1111	input current	Clock 2 of 'LS196	YCC - IWAA,	V1 - 2.7 V				80			80	~~
		Clock 2 of 'LS197						40			40	
		Data, Load						-0.4			-0.4	
	Low-level	Clear						-0.8			-0.8	
HL	Input current	Clock 1	VCC = MAX.	V_{\parallel} = 0.4 V				-2.4			-2.4	mΑ
	inpat content	Clock 2 of 'LS196						-2.8			-2.8	ļ
		Clock 2 of 'LS197					Ī	-1.3			-1.3	
los	Short-circuit outp	out current\$	VCC = MAX			-20		-100	-20		-100	mΑ
ICC	Supply current		V _{CC} = MAX,	See Note 5	· 		16	27		16	27	mΑ

 $^{^\}dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 5. I_{CC} is measured with all inputs grounded and all outputs open.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER#	FROM (INPUT)	то (оитрит)	TEST CONDITIONS	·	154LS1 174LS1		SN SN	דואט		
	(HVPO1)	(0017017		MIN	TYP	MAX	MIN	TYP	MAX	1
f _{max}	Clock 1	Q _A		30	40		30	40		MHz
t P LH	Clock 1	QA			8	15		8	15	ns
†PHL	CIOCK	υд			13	20		14	21	
^t PLH	Clock 2	u _B			16	24		12	19	ns
tPHL.	01002				22	33		23	35	113
[†] PLH	Clock 2	0-	C _L = 15 pF,		38	57		34	51	п\$
^t PHL	CIOCK 2	QC			41	62		42	63	113
[†] PLH	Clock 2	0-	R _L = 2 kΩ, See Note 6		12	18		55	78	
^t PH↓	CIOCK 2	□ QD	See Note 6		30	45		63	95	ns
ФLH					20	30		18	27	
tPHL	A, B, C, D	QA, QB, QC QD			29	44		29	44	ns
^t PLH	Load	Any			27	41		26	39	
tPHL	LOAG	Any		19	30	45		30	45	ns.
tpH L	Clear	Any			34	51		34	51	ns

[#]f_{max} ≡ maximum count frequency.

NOTE 6: Load circuit, input conditions, and voltage waveforms are the same as those shown for the '176, '177 except that $t_r \le 15 \text{ ns}$, $t_f \le 6 \text{ ns}$, and $V_{ref} = 1.3 \text{ V}$ (as opposed to 1.5 V).



 $^{^{\}ddagger}$ All typical values are at $V_{CC} = 5 \text{ V}$, $T_{A} = 25^{\circ}\text{C}$.

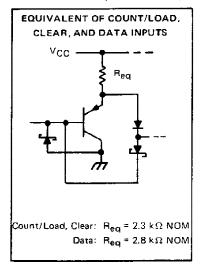
^{\$}Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

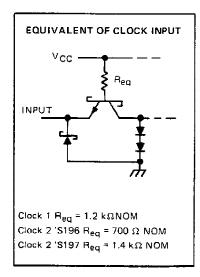
^{*} QA outputs are tested at specified IQL plus the limit value of I_|L for the clock-2 input. This permits driving the clock-2 input while maintaining full fan-out capability.

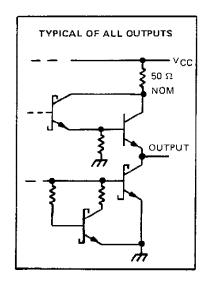
 $tp_{LH} \equiv propagation delay time, low-to-high-level output, <math>tp_{HL} \equiv propagation delay time, high-to-low-level output.$

SN54S196, SN54S197, SN74S196, SN74S197 100-MHz PRESETTABLE DECADE OR BINARY COUNTERS/LATCHES

schematics of inputs and outputs







absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)																					7 V
Input voltage			_	_				-			-		_	-	٠	_		_	÷	5.	5 V
Operating free-air temperature range:	SN	1549	319	96,	5N!	548	197	7 Ci	rcu	its							_	55°	C to	125	5°C
	SN	1749	319	96,	SN	74S	197	7 Çi	rcu	its								C	°C	to 70)°C
Storage temperature range																		65°	C to	150	o°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54	S196, SN5	4S197	SN745	4\$197				
		MIN	MOM	MAX	MIN	NOM	MAX	UNIT		
Supply voltage, VCC		4.5	5	5.5	4.75	5	5.25	V		
High-level output current, IOH				-1			-1	mA		
Low-level output current, IOL				20			20	mA		
Clark former	Clock-1 input	0		100	0		100	MHz		
Clock frequency	Clock-2 input	0		50	0		50	- IVITIZ		
	Clock-1 input	5			5					
6.1	Clack-2 input	10			10]		
Pulse width, t _W	Clear	30			30		•	ns		
	Load	Load	Load	5			5			
In the later of the New 20	High-level data	31			31					
Input hold time, th (see Note 3)	Low-level data	31			31			ns		
Inner to Jaco Nata 2)	High-level data	61			61					
Input setup time, t _{su} (see Note 3)	Low-level data	6 1			61			ns		
Count enable time, ten (see Note 4)		12	•	•	12	•		ns		
Operating free-air temperature, TA		-55		125	0		70	°C		

- NOTES: 3. Setup and hold times are with respect to the falling edge of the load input.
 - 4. Minimum count enable time is the interval immediately preceding the negative-going edge of the clock pulse during which interval the count/load and clear inputs must both be high to ensure counting.



SN54S196, SN54S197, SN74S196, SN74S197 100-MHz PRESETTABLE DECADE OR BINARY COUNTERS/LATCHES

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS †			SN54S196, SN74S196			SN54S197, SN74S197			UNIT		
						MIN	TYP‡	MAX	MIN	TYP#	MAX		
ViH						2			2			V	
v_{tL}								0.8			8.0	V	
Vik		V _{CC} = MIN,	I _I = -18 mA					-1.2			-1.2	V	
Voн		VCC = MIN,			548	2.5	3.4		2.5	3.4		v	
YOH			IOH = -1 mA		748	2.7	3.4		2.7	3.4		Ť	
VOL		V _{CC} = MIN, loL = 20 mA €	V _{IH} = 2 V,	V _{IL} = (.V 8.0			0.5			0.5	٧	
t _l		V _{CC} = MAX,	V _I ≈ 5.5 V			1		1			1	mΑ	
Len	Clock 1, clock 2	V _{CC} = MAX,	V = 2.7 V	•				150			150		
IIH	All other inputs							50			50	μΑ	
IIL	Data, Load Clear	- NAV	V _I = 0.5V					- 0.75			- 0.75	mΑ	
	Clock 1	VCC - NIAA,						-8			8	mΑ	
	Clock 2	1						-10			-6	mΑ	
¹ 05 [§]		V _{CC} = MAX	-			-30		-110	-30		-110	mA	
lan	-	V _{CC} = MAX,	San Nota E		54S		75	110		75	110		
lcc		1 *CC = WAA,	288 14018 0		74\$	75		120		75	120	mA	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions,

NOTE 5: ICC is measured with all input grounded and all outputs open.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER#	(FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	SN54S196, SN74S196			SN54S197, SN74S197			UNIT
_				MIN	TYP	MAX	MIN	TYP	MAX	1
fmax	Clock 1	a _A	R_L = 280 Ω , C_L = 15 pF, See Note 7	100	140		100	140	٠	MHz
^t PLH	Clack 1	Q _A			5	10		5	10	ns
^t PHL					6	10		6	10	
[†] PLH	Clock 2	ock 2 QB			5	10		5	10	лs
[†] PHL					8	12		8	12	
^t PLH	Clock 2	σC			12	18		12	18	ns
[‡] PHL	CIDER 2				16	24		15	22	
tPLH .	Clock 2	α _D			5	10		18	27	ns
^t PHL	CIOCK 2				8	12	· · ·	22	33	
[†] PLH	A,B,C,D	$\alpha_{A}, \alpha_{B}, \alpha_{C}, \alpha_{D}$			7	12		7	12	
†PHL					12	18		12	18	ns
^t PLH	Load	Any			10	18	İ	10	18	
^t PHL	COBU				12	18		12	18	ns
^t PHL	Clear	Any			26	37		26	37	ns

 $^{\#}f_{max} = maximum count frequency.$

NOTE 7: Load circuit, input conditions, and voltage waveforms are the same as those shown in Section 1.

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

¶ Q_A outputs are tested at $I_{OL} = 20 \text{ mA}$ plus the limit value of I_{IL} for the clock-2 input. This permits driving the clock-2 input while fanning out to 10 Series 54S/74S loads.

[§] Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

 $t_{\mbox{PLH}}$ = propagation delay time, low-to-high-level output.

tpHL = propagation delay time, high-to-low-level output.

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